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APPLICATION NO.	FI	ILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
09/902,277	(07/09/2001	Gurtej S. Sandhu	MI22-1780	1605	
21567	7590	10/21/2003		EXAM	EXAMINER	
WELLS ST				SCHILLINGER, LAURA M		
601 W. FIRS		UE, SUITE 1300 201		ART UNIT PAPER NUMBER		
,			·	2813		

DATE MAILED: 10/21/2003

--Please-find-below-and/or attached-an-Office-communication-concerning-this-application-or-proceeding.

			(m)				
	Application No.	Applicant(s)					
·	09/902,277	SANDHU ET AL.					
Office Action Summary	Examiner	Art Unit					
	Laura M Schillinge	er 2813					
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply							
A SHORTENED STATUTORY PERIOD FOR REPL THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1. after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a rep - If NO period for reply is specified above, the maximum statutory period - Failure to reply within the set or extended period for reply will, by statut - Any reply received by the Office later than three months after the mailin earned patent term adjustment. See 37 CFR 1.704(b). Status	136(a). In no event, however, within the statutory mining will apply and will expire Se, cause the application to	ver, may a reply be timely filed num of thirty (30) days will be considered time IX (6) MONTHS from the mailing date of this become ABANDONED (35 U.S.C. § 133).	ely. communication.				
1) Responsive to communication(s) filed on 21	July 2003 .						
2a)⊠ This action is FINAL . 2b)□ Ti	his action is non-fin	al.					
Since this application is in condition for allow closed in accordance with the practice under Disposition of Claims			the merits is				
4) Claim(s) 51-58 is/are pending in the applicati	on.						
4a) Of the above claim(s) is/are withdra	awn from considera	tion.					
5) Claim(s) is/are allowed.							
6)⊠ Claim(s) <u>51-58</u> is/are rejected.							
7) Claim(s) is/are objected to.							
8) Claim(s) are subject to restriction and/o	or election requiren	nent.					
Application Papers							
9)☐ The specification is objected to by the Examiner.							
10)☐ The drawing(s) filed on is/are: a)☐ accepted or b)☐ objected to by the Examiner.							
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).							
11) ☐ The proposed drawing correction filed on is: a) ☐ approved b) ☐ disapproved by the Examiner.							
If approved, corrected drawings are required in reply to this Office action.							
12)☐ The oath or declaration is objected to by the E	xaminer.						
Priority under 35 U.S.C. §§ 119 and 120							
13) Acknowledgment is made of a claim for foreig	n priority under 35	U.S.C. § 119(a)-(d) or (f).					
a) ☐ All b) ☐ Some * c) ☐ None of:							
 Certified copies of the priority document 	its have been recei	ved.					
2. Certified copies of the priority documen							
 3. Copies of the certified copies of the price application from the International B * See the attached detailed Office action for a lis 	ureau (PCT Rule 1	7.2(a)).	al Stage				
14) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).							
a) The translation of the foreign language pr	rovisional application	on has been received.					
Attachment(s)							
Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawing Review (PTO-948) Information Disclosure Statement(s) (PTO-1449) Paper No(s)	5) 🔲	Interview Summary (PTO-413) Paper Notice of Informal Patent Application (FO) Other:					

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DETAILED ACTION

This Office Action is in Response to Paper No.19, dated 8/4/03.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

(e) the invention was described in-

(1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effect under this subsection of a national application published under section 122(b) only if the international application designating the United States was published under Article 21(2)(a) of such treaty in the English language; or

(2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that a patent shall not be deemed filed in the United States for the purposes of this subsection based on the filing of an international application filed under the treaty defined in section 351(a).

Claims 51-57 are rejected under 35 U.S.C. 102(e) as being anticipated by Tseng et al ('802).

In reference to claim 51, Tseng et al ('802) teaches a method comprising:

Forming a gate (Col.2, lines: 45-55)

Forming a polycrystalline TFT layer over the gate (Col.2, lines: 45-55)

Forming a fluorine containing layer proximate to the polycrystalline TFT layer, the fluorine layer comprising W (Col.2, lines: 45-55) and

Transferring F into the polycrystalline TFT layer from the F containing layer (Col.2-3, lines: 60-5), the transferred F passivating the polycrystalline TFT layer in the bottom gated TFT (Col.3 (lines: 45-55)

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In reference to claim 52, Tseng et al ('802) teaches wherein the polycrystalline TFT comprises Si (Col.2, lines: 50-55).

In reference to claim 53, Tseng et al ('802) teaches wherein the forming a F containing layer comprises forming a sacrificial F containing layer over the TFT layer by CVD utilizing WF(6) and SiH(4) precursors (Col.2, lines: 55-60).

In reference to claim 54, Tseng et al ('802) teaches further comprising after the transferring F, removing the F-containing layer from over the TFT layer (Col.3, lines: 60-63)).

In reference to claim 55, Tseng et al ('802) teaches a method comprising:

Forming a gate (Col.2, lines: 45-55)

Forming a polycrystalline TFT layer over the gate (Col.2, lines: 45-55)

Forming a fluorine containing layer proximate to the polycrystalline TFT layer, the fluorine layer comprising W (Col.2, lines: 45-55);

Providing a buffering layer intermediate the TFT layer and the F containing layer (Col.3, lines: 15-25); and

Transferring F into the polycrystalline TFT layer from the F containing layer (Col.2-3, lines: 60-5).

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In reference to claim 56, Tseng et al ('802) wherein the F-containing layer comprises W (Col.2,

lines: 45-55).

In reference to claim 57, Tseng et al ('802) wherein the buffering layer comprises SiO₂ (Col.3, lines: 15-25).

Allowable Subject Matter

The following is a statement of reasons for the indication of allowable subject matter:

Claim 58 recites wherein the polycrystalline thin film layer is germanium. Although Germanium polycrystalline layers are well-known in the art of semiconductor technology, Tseng makes no suggestion to modify his teachings to include forming a germanium polycrystalline silicon layer rather than a polycrystalline silicon layer. Absent such a suggestion or teaching, claim 58 contains allowable subject matter.

Response to Arguments

Applicant's arguments filed 8/4/03 in Paper No.19 have been fully considered but they are not persuasive.

Applicant argues that claim 51 as amended is not anticipated by Tseng because Tseng fails to teach a passivating step as claimed by the Applicant. However, upon review of Applicant's own specification, the "passivating step" referred to is merely the bonding of the F

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atoms into the grain boundaries or as Tseng teaches the dangling silicon bonds. Therefore Tseng does teach a passivating step as defined by the Applicant.

Applicant argues with respect to claim 55 that Tseng fails to teach a buffering layer however provides no arguments as to why the silicon dioxide layer taught by Tseng fails to anticipate the applicant's "buffer layer". Consequently, such an argument is not deemed persuasive. Further Applicant argues that the claim language requires transferring fluorine into a polycrystalline layer from a overlying fluorine containing layer. However, Applicant's claim language does not require what Applicant's arguments suggest. Specifically, Applicant's claim language does not require that the fluorine layer be "overlying". Further Applicant's claim language does not require that the transferred fluorine remain within the polycrystalline film.

Conclusion

THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event,

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however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Laura M Schillinger whose telephone number is (703) 308-6425. The examiner can normally be reached on M-T, R-F 7:00-5:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Carl W Whitehead, Jr. can be reached on (703) 308-4940. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9306.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

LMS

October 18, 2003

PRIMARY EXAMINER

JPLI GGY CENTER 2800